

Notice of References Cited	Application/Control No. 10/642,334	Applicant(s)/Patent Under Reexamination CHENG, DAR-HSIANG	
	Examiner Hau V Phan	Art Unit 3618	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,793,622	12-1988	Sydlow, Thomas	280/40
*	B	US-5,161,635	11-1992	Kiffe, Horst-Gregor	280/DIG.6
*	C	US-5,582,419	12-1996	Lucia et al.	280/42
*	D	US-5,857,684	01-1999	Liao et al.	280/40
*	E	US-6,152,465	11-2000	Shieh, Shanq-Ching	280/DIG.6
*	F	US-6,168,174	01-2001	MacDougall, Alexander Stewart	280/47.34
*	G	US-6,296,260	10-2001	Schiavone, Dominick M.	280/47.2
*	H	US-6,299,195	10-2001	Chan, Corwyn	280/651
*	I	US-6,435,539	08-2002	Wu, David	280/652
*	J	US-6,695,324	02-2004	Wu, David	280/47.315
*	K	US-6,715,785	04-2004	Shieh, Shanq-Ching	280/651
*	L	US-6,749,214	06-2004	Shieh, Shanq-Ching	280/651
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.